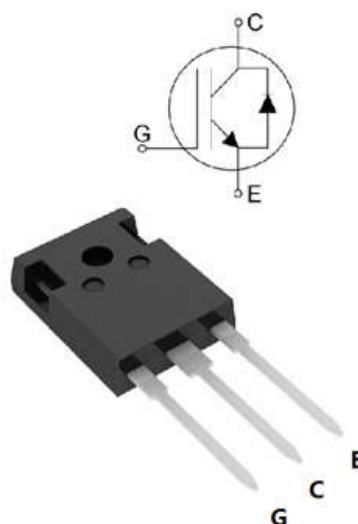


H&M Semi Field Stop Trench IGBTs offer low switching losses, high energy efficiency and high avalanche ruggedness for soft switching applications such as inductive heating, microwave oven, etc.

$V_{CE}$	1200	V
$I_C$	15	A
$V_{CE(SAT)} \quad I_C=15A$	1.9	V

## FEATURES

- Trench-Stop Technology offering :
  - High speed switching
  - High ruggedness, temperature stable
  - Low  $V_{CEsat}$
  - Easy parallel switching capability due to positive temperature coefficient in  $V_{CEsat}$
- Soft current turn-off waveforms
- Enhanced avalanche capability



## APPLICATION

- Inductive cooking
- Inverterized microwave ovens
- Resonant converters
- Soft switching applications

Product	Package	Packaging
HM15N120FT	TO247	Tube

## Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter Breakdown Voltage	$V_{CE}$	1200	V
DC collector current, limited by $T_{jmax}$ $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	$I_C$	30 15	A
Diode Forward current, limited by $T_{jmax}$ $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	$I_F$	30 15	A
Continuous Gate-emitter voltage	$V_{GE}$	$\pm 20$	V
Transient Gate-emitter voltage	$V_{GE}$	$\pm 30$	V
Turn off safe operating area $V_{CE} \leq 1200V$ , $T_j \leq 150^{\circ}C$	-	45	A
Pulsed collector current, $V_{GE}=15V$ , $t_p$ limited by $T_{jmax}$	$I_{CM}$	45	A
Power dissipation , $T_j=25^{\circ}C$	$P_{tot}$	260	W
Operating junction temperature	$T_j$	$-40...+150$	$^{\circ}C$
Storage temperature	$T_s$	$-55...+150$	$^{\circ}C$
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s	-	260	$^{\circ}C$

## Thermal Resistance

Parameter	Symbol	Max. Value	Unit
IGBT thermal resistance, junction - case	$R_{\theta(j-c)}$	0.7	K/W
Diode thermal resistance, junction - case	$R_{\theta(j-c)}$	1.5	K/W
Thermal resistance, junction - ambient	$R_{\theta(j-a)}$	40	K/W

## Electrical Characteristics of the IGBT (T<sub>j</sub>= 25°C unless otherwise specified) :

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
Collector-Emitter breakdown voltage	BV <sub>CES</sub>	V <sub>GE</sub> =0V, I <sub>C</sub> =250μA	1200	-	-	V
Gate threshold voltage	V <sub>GE(th)</sub>	V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> =250μA	5.2	5.8	6.8	V
Collector-Emitter Saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =15A T <sub>j</sub> = 25°C T <sub>j</sub> = 150°C	- -	1.9 2.3	2.3 -	V
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V T <sub>j</sub> = 25°C T <sub>j</sub> = 150°C	- -	- -	100 1000	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> = 0V, V <sub>GE</sub> = ±20V	-	-	100	nA
Transconductance	g <sub>fs</sub>	V <sub>CE</sub> = 20V, I <sub>C</sub> = 15A	-	10	-	S

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic</b>						
Input capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz	-	1520	-	pF
Output capacitance	C <sub>oes</sub>		-	52	-	
Reverse transfer capacitance	C <sub>res</sub>		-	30	-	
Gate charge	Q <sub>G</sub>	V <sub>CC</sub> = 960V, I <sub>C</sub> = 15A, V <sub>GE</sub> = 15V	-	84	-	nC

## Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic , at <math>T_j = 25^\circ \text{C}</math></b>						
Turn-on delay Time	$t_{d(on)}$	$V_{CC} = 600V, I_C = 15A,$ $V_{GE} = 0/15V,$ $R_g = 12\Omega$	-	24	-	ns
Rise Time	$t_r$		-	17	-	ns
Turn-off delay time	$t_{d(off)}$		-	80	-	ns
Fall time	$t_f$		-	79	-	ns
Turn-on Energy	$E_{on}$			1.57	-	mJ
Turn-off energy	$E_{off}$		-	0.28	-	mJ

## Electrical Characteristics of the DIODE ( $T_j = 25^\circ \text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
<b>Dynamic</b>						
Diode Forward Voltage	$V_{FM}$	$I_F = 15A$	-	2.3	-	V
Reverse Recovery Time	$T_{rr}$	$I_F = 10A,$ $di/dt = 200A/\mu s$	-	70	-	ns
Reverse Recovery Current	$I_{rr}$		-	5	-	A
Reverse Recovery Charge	$Q_{rr}$		-	1600	-	nC

Fig. 1 FBSOA characteristics

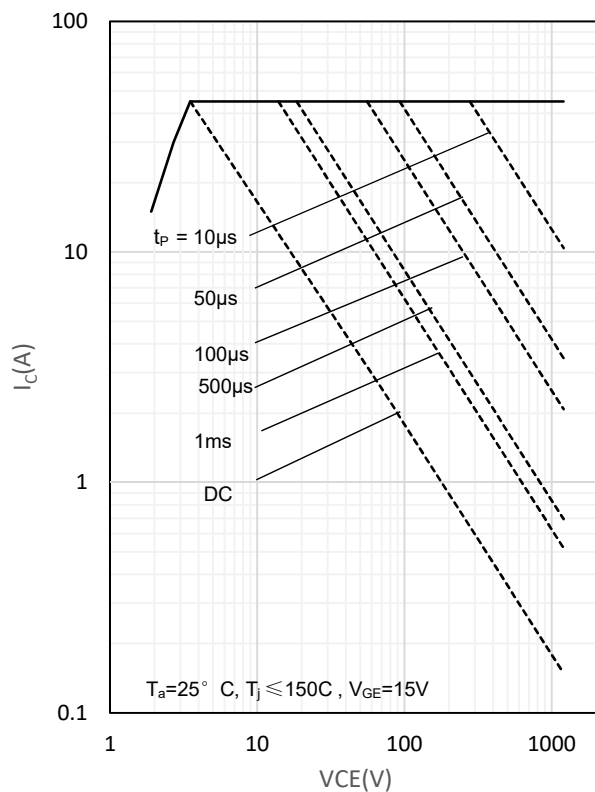


Fig. 2 Load Current vs. Frequency

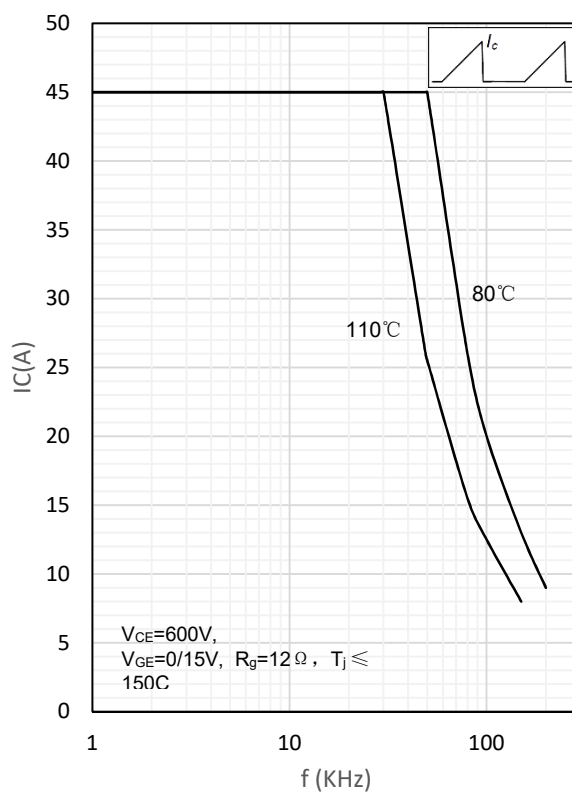


Fig. 3 Output characteristics

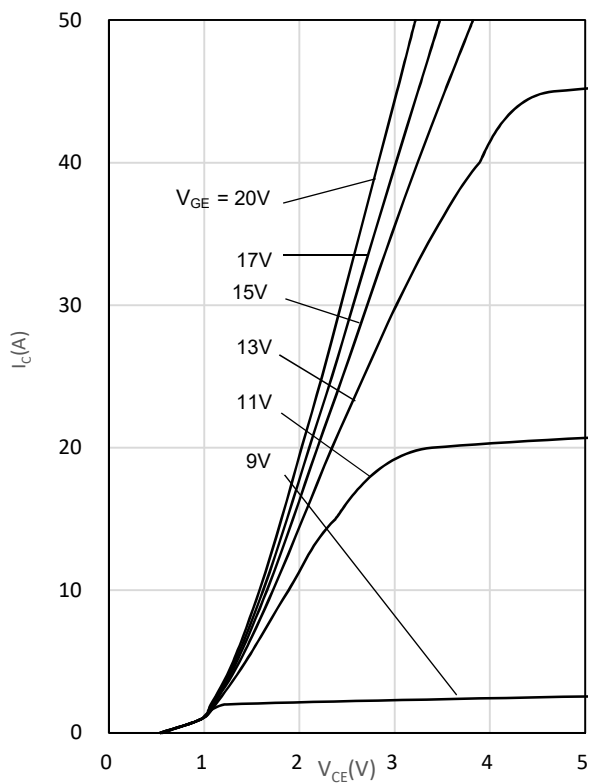


Fig. 4 Saturation voltage characteristics

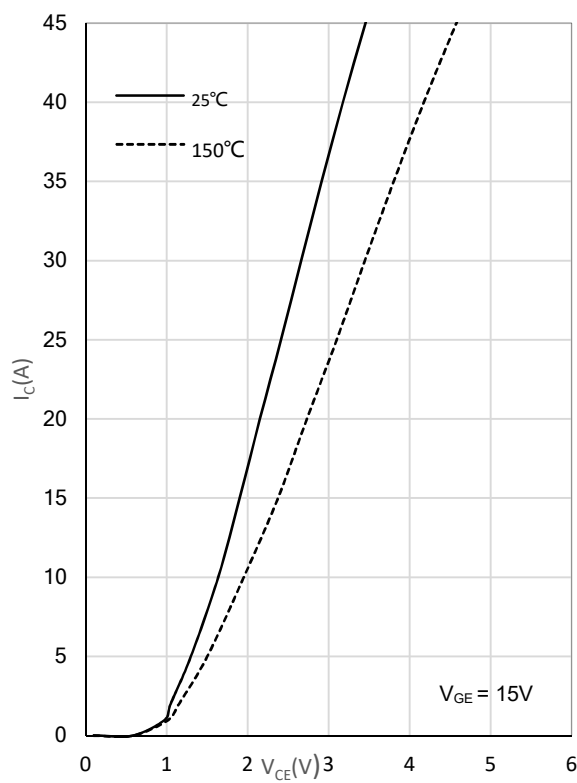


Fig. 5 Switching times vs. gate resistor

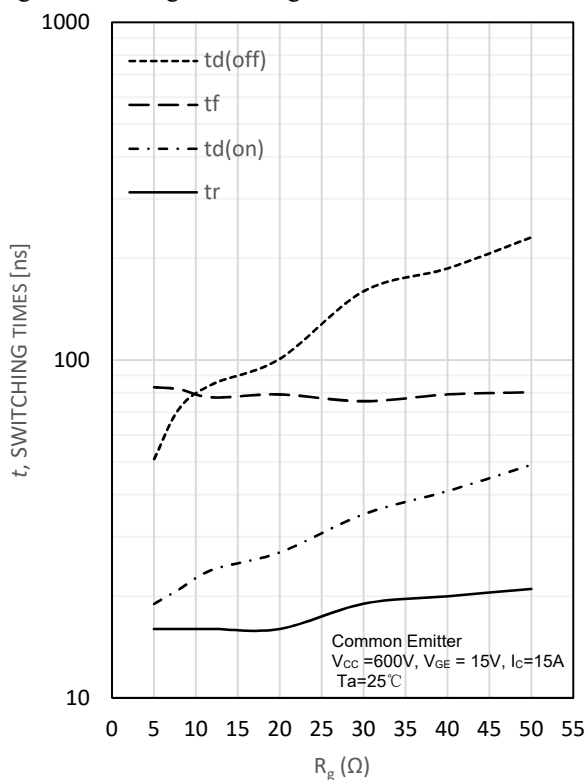


Fig. 6 Switching times vs. collector current

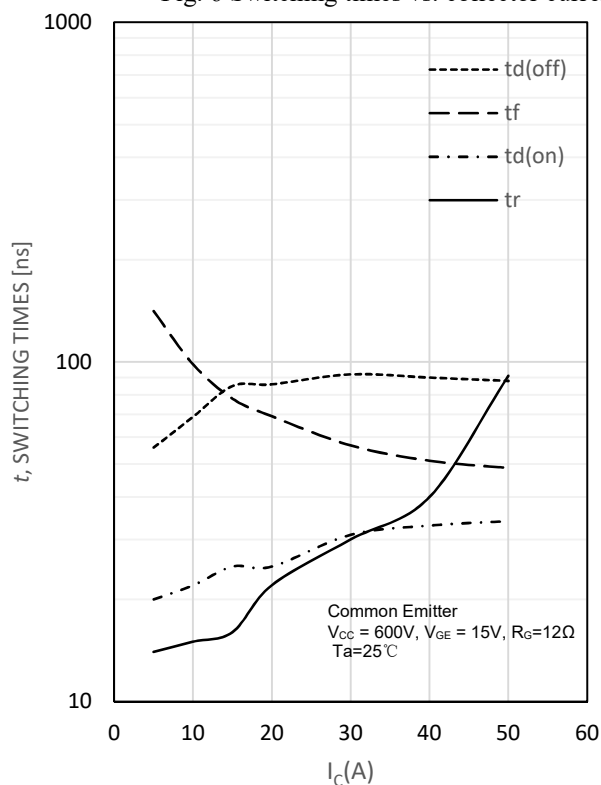


Fig. 7 Switching loss vs. gate resistor

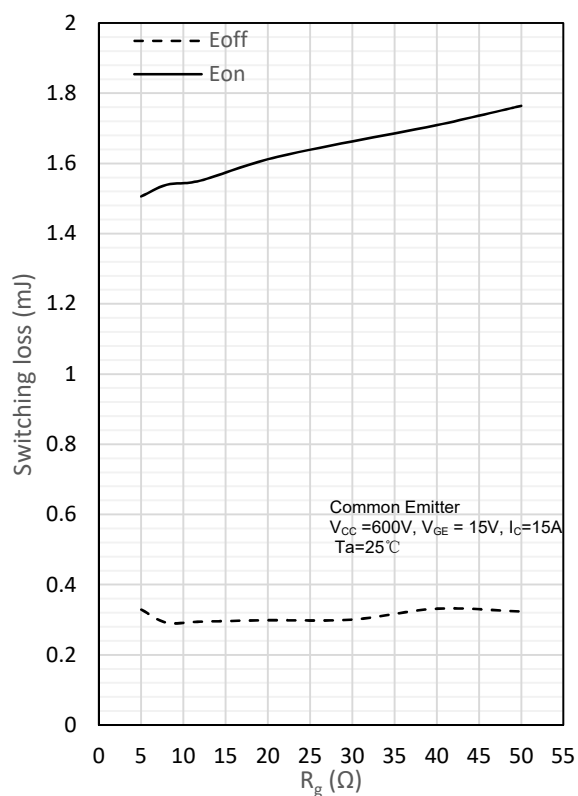


Fig. 8 Switching loss vs. collector current

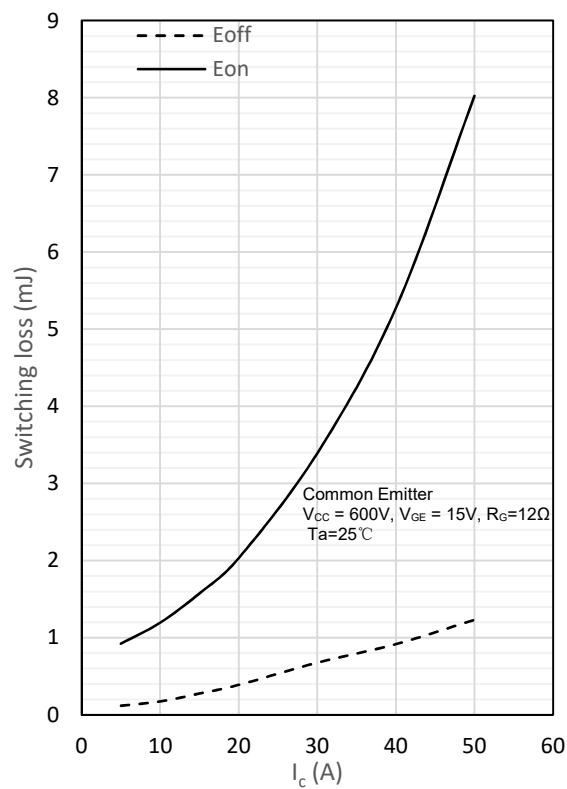
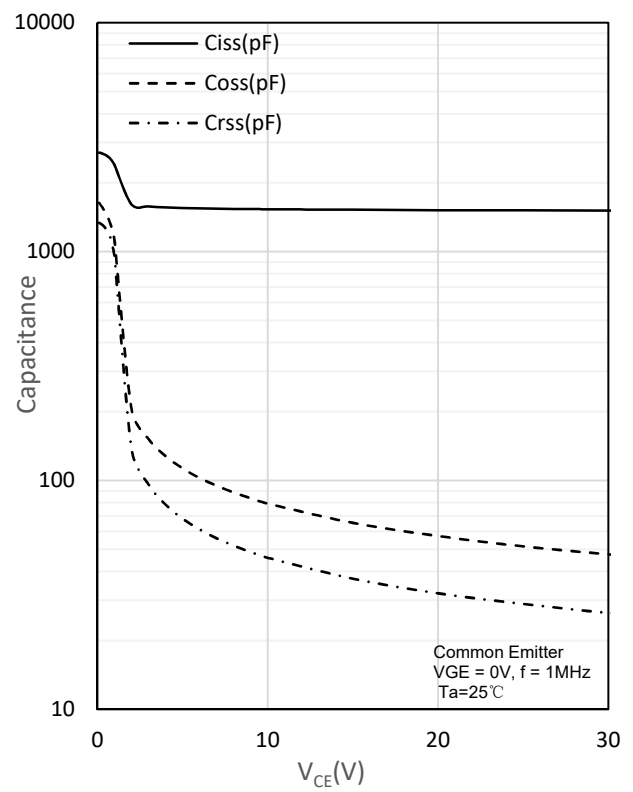
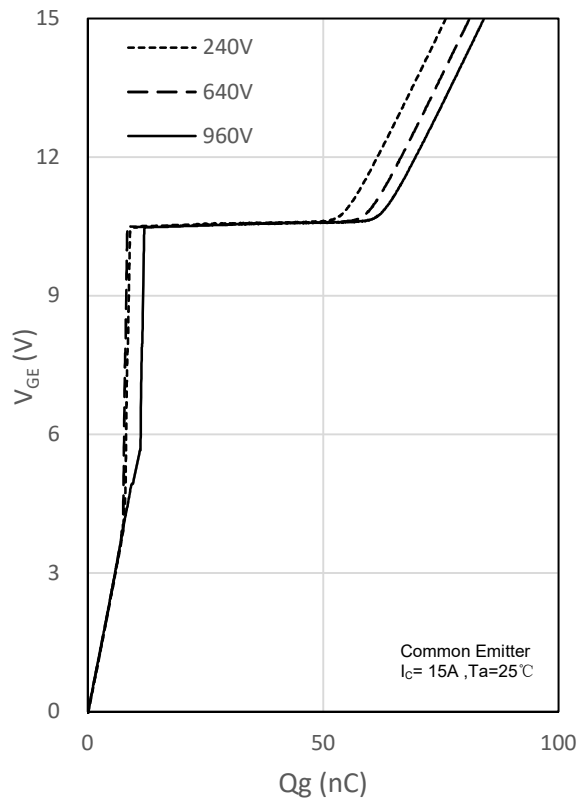
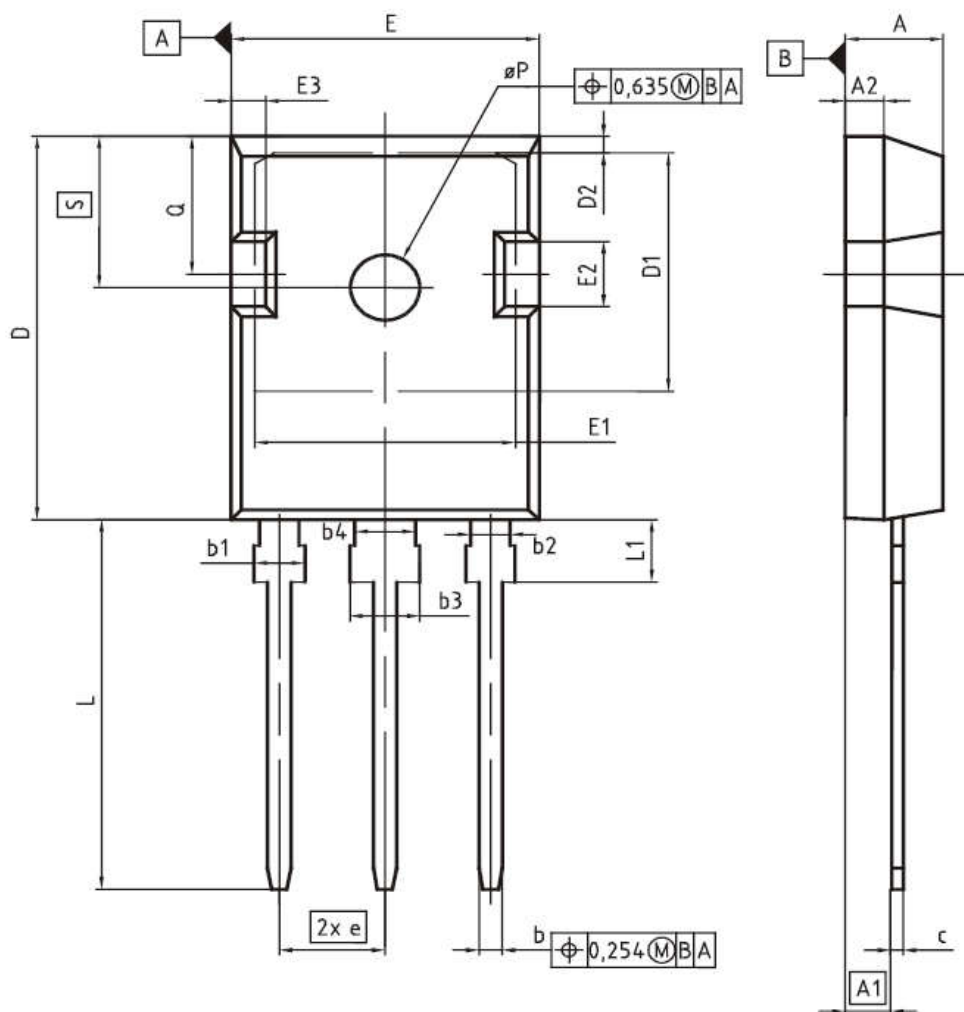


Fig. 9 Gate charge characteristics

Fig. 10 Capacitance characteristics



## PG-TO247-3



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	0.190	0.205
A1	2.27	2.54	0.089	0.100
A2	1.85	2.16	0.073	0.085
b	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
c	0.55	0.68	0.022	0.027
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.13	0.618	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	2.60	0.039	0.102
e	5.44 (BSC)		0.214 (BSC)	
N	3		3	
L	19.80	20.32	0.780	0.800
L1	4.10	4.47	0.161	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248